	Application/Control No.	Applicant(s)/Patent Under Reexamination
Search Notes	10016223	CHANG ET AL.
*1001622	Examiner	Art Unit
1001022	AJAY BHATIA	2145
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SEARCHED				
Class	Subclass	Date	Examiner	
709	227	12/28/2010	AB	
358	1.15	12/28/2010	AB	

SEARCH NOTES			
Search Notes	Date	Examiner	
East Search	12/28/2010	AB	
Google Scholar	12/28/2010	AB	
ODP	12/28/2010	AB	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
709	227	12/28/2010	AB	
358	1.15	12/28/2010	AB	

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